Sear	cn Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/633,580	TANISHIMA ET AL.
Examiner	Art Unit
Ly D. Pham	2827

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Class	Subclass	Date	Examiner
365	200	5/16/2005	LP
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEA (INCLUDING)	ARCH NOT SEARCH	ES STRATEGY)
		DATE	EXMR
East		5/16/2005	LP
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